

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10597856	LEE, KEUN-JIN
	Examiner	Art Unit
	Hal I Kaplan	2836

SEARCHED			
Class	Subclass	Date	Examiner
307	39	10/23/2008	HK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US- PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	10/23/2008	HK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
Interference Search History Printout		10/23/2008	HK

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